

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10807859	KURACHI ET AL.
	<b>Examiner</b>  Merkling, Matthew J	<b>Art Unit</b>  1709

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
204	424-429	1/19/07	MJM
205	783.5-785	1/19/05	MJM
73	23.31-23.32	1/19/05	MJM

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted with Primary Examiner Kaj Olsen regarding search strategies and techniques in 204 and 205	1/10/07	MJM
Text Search in EAST (see search history printout)	1/19/07	MJM
Inventorship search conducted	1/19/07	MJM

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>